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June 2014

FDMC8884

N-Channel PowerTrench[®] MOSFET 30 V, 15 A, 19 m Ω

Features

- Max $r_{DS(on)} = 19 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 9.0 \text{ A}$
- Max $r_{DS(on)}$ = 30 m Ω at V_{GS} = 4.5 V, I_D = 7.2 A
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

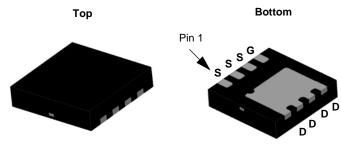


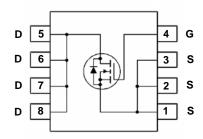
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Application

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook





MLP 3.3x3.3

MOSFET Maximum Ratings $T_A = 25 \, ^{\circ}\text{C}$ unless otherwise noted

| Symbol | Parame | ter | | Ratings | Units |
|-------------------|---|------------------------|-----------|-------------|-------|
| V_{DS} | Drain to Source Voltage | | | 30 | V |
| V_{GS} | Gate to Source Voltage | | | ±20 | V |
| | Drain Current -Continuous | T _C = 25 °C | | 15 | |
| I_D | -Continuous | T _A = 25 °C | (Note 1a) | 9.0 | Α |
| | -Pulsed | | | 40 | |
| E _{AS} | Single Pulse Avalanche Energy | | (Note 3) | 24 | mJ |
| Б | Power Dissipation | T _C = 25 °C | | 18 | W |
| P_{D} | Power Dissipation | T _A = 25 °C | (Note 1a) | 2.3 | VV |
| T_J , T_{STG} | Operating and Storage Junction Temperat | ture Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 6.6 | °C/W |
|-----------------|---|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|-------------|-----------|------------|------------|
| FDMC8884 | FDMC8884 | MLP 3.3x3.3 | 13 " | 12 mm | 3000 units |

Electrical Characteristics T_J = 25 °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|---|-----|-----|------|-------|
| Off Chara | acteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 30 | | | V |
| ΔBV _{DSS} _ΔT _J _ | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | 22 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V _{GS} = 0 V | | | 1 | μА |
| D00 | | T _J = 125 °C | | | 250 | |
| I _{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 1.4 | 1.9 | 2.5 | V |
|----------------------------------|--|--|-----|-----|-----|-------|
| $\Delta V_{GS(th)}$ ΔT_J | Gate to Source Threshold Voltage Temperature Coefficient | I _D = 250 μA, referenced to 25 °C | | -6 | | mV/°C |
| | | $V_{GS} = 10 \text{ V}, I_D = 9.0 \text{ A}$ | | 16 | 19 | |
| r _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 4.5 \text{ V}, I_D = 7.2 \text{ A}$ | | 22 | 30 | mΩ |
| , , | | $V_{GS} = 10 \text{ V}, I_D = 9.0 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 22 | 30 | |
| 9 _{FS} | Forward Transconductance | V _{DD} = 5 V, I _D = 9.0 A | | 24 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 45 V V 0 V | 513 | 685 | pF |
|------------------|------------------------------|--|-----|-----|----|
| Coss | Output Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz | 110 | 150 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 101112 | 76 | 115 | pF |
| R _a | Gate Resistance | | 1.4 | 2.1 | Ω |

Switching Characteristics

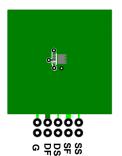
| t _{d(on)} | Turn-On Delay Time | | 6 | 12 | ns |
|---------------------|-------------------------------|--|-----|-----|----|
| t _r | Rise Time | $V_{DD} = 15 \text{ V}, I_{D} = 9.0 \text{ A},$ | 2 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | 15 | 27 | ns |
| t _f | Fall Time | | 2 | 10 | ns |
| 0 | Total Gate Charge | V _{GS} = 0 V to 10 V | 10 | 14 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 15 \text{ V}$ | 5.0 | 7.0 | nC |
| Q_{gs} | Total Gate Charge | I _D = 9.0 A | 1.8 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | 2.2 | | nC |

Drain-Source Diode Characteristics

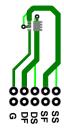
| V _{SD} | 1 Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 9.0 \text{ A}$ (Note 2) | 0.86 | 1.2 | V |
|-----------------|---|--|------|-----|----|
| | | $V_{GS} = 0 \text{ V}, I_{S} = 1.6 \text{ A}$ (Note 2) | 0.76 | 1.2 | |
| t _{rr} | Reverse Recovery Time | -I _E = 9.0 A, di/dt = 100 A/μs | 13 | 18 | ns |
| Q _{rr} | Reverse Recovery Charge | $H_F = 9.0 \text{ A}, \text{ divat} = 100 \text{ A}/\mu\text{S}$ | 3 | 10 | nC |

NOTES:

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.
- 3. E_{AS} of 24 mJ is based on starting T_J = 25 $^{\circ}C$, L = 1 mH, I_{AS} = 7 A, V_{DD} = 30 V, V_{GS} = 10 V. 100% test at L = 3 mH, I_{AS} = 4 A .

Typical Characteristics T_J = 25 °C unless otherwise noted

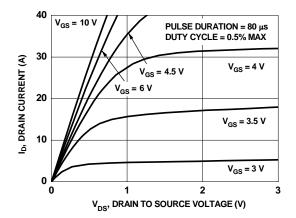
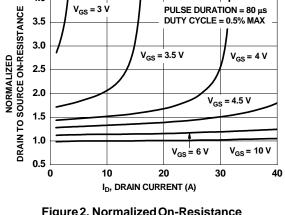


Figure 1. On-Region Characteristics



4.0

Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

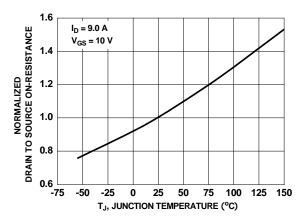


Figure 3. Normalized On-Resistance vs Junction Temperature

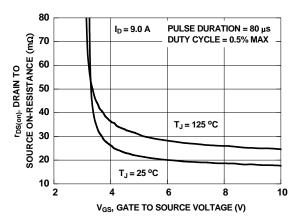


Figure 4. On-Resistance vs Gate to Source Voltage

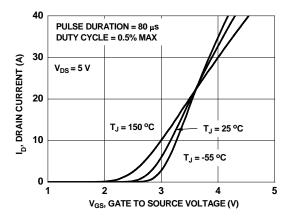


Figure 5. Transfer Characteristics

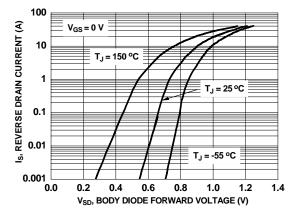


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

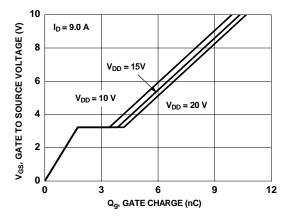


Figure 7. Gate Charge Characteristics

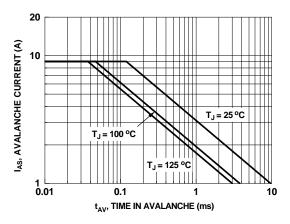


Figure 9. Unclamped Inductive Switching Capability

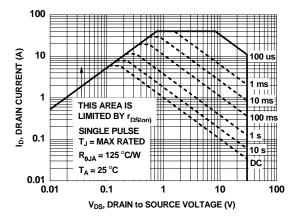


Figure 11. Forward Bias Safe Operating Area

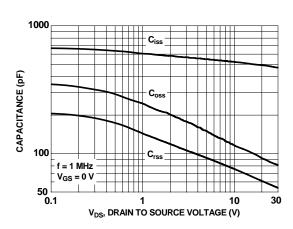


Figure 8. Capacitance vs Drain to Source Voltage

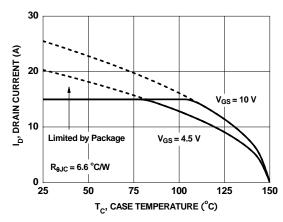


Figure 10. Maximum Continuous Drain Current vs Case Temperature

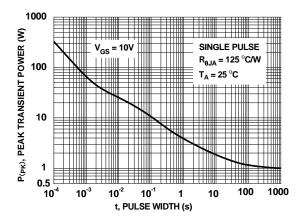


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

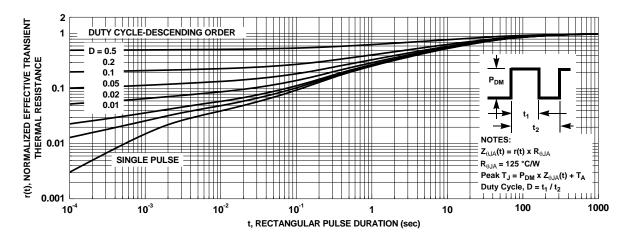
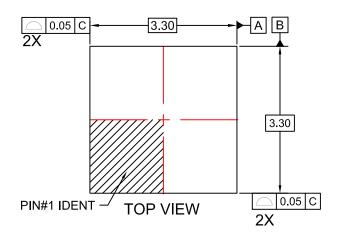
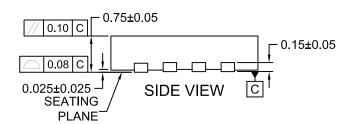
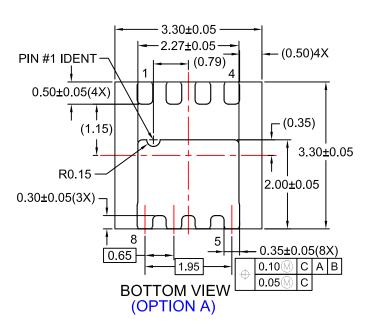
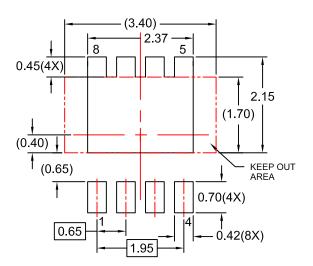


Figure 13. Transient Thermal Response Curve

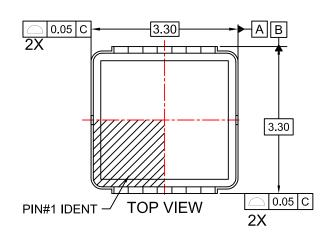


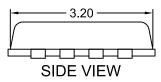


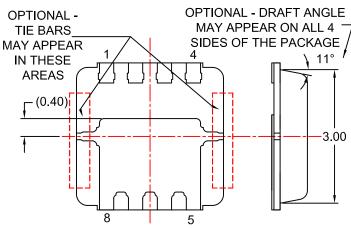




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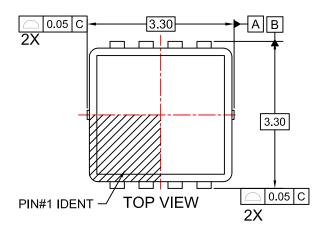


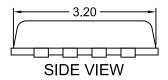


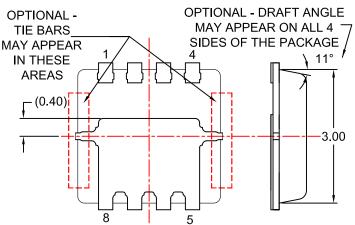


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(OPTION B)







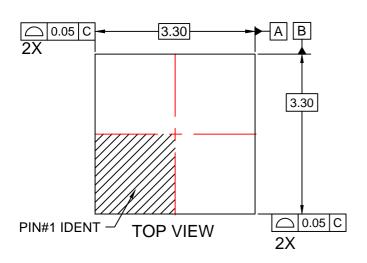


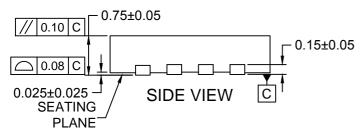
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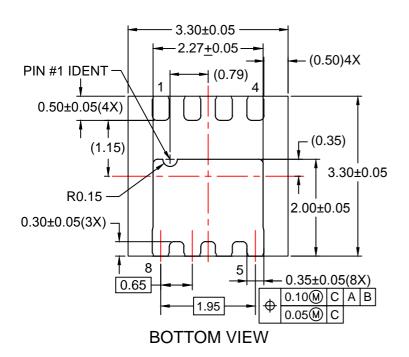
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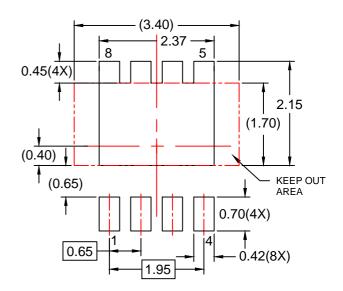
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